Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/769,107	LEE ET AL.	
Examiner	Art Unit	
Khanh B. Duong	2822	

SEARCHED			
Class	Subclass	Date	Examiner
<u></u>			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interferen prin		11/16/2006	KBD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST update (text search: see search history printout)	11/16/2006	KBD
Discussed with primary examiner Michael Trinh	11/16/2006	KBD
PALM inventor name search	11/16/2006	KBD
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